LIST OF ART CITED BY APPLICANT				ATTY. DOCKET NO. K-0259		APPLN. SERIAL NO. 09/773,574	
の「記」(PTO-1449)				APPLICANT(S) Seung June YI, Young Dae LEE, and Sung Lark KWON			
MAR 0 7 2005 S				FILING DATE 2/2/2001		GROUP 2663	
	DOCUMENTS	•				•	
EXAMINER'S	PATENINO.	*ISSUE DATE	*INVE	NTOR NAME	CLASS	SUBCLASS	FILING DATE
ļ							
 					<u> </u>		
ļ			 				
					·		
	<u> </u>					<u> </u>	
U.S. PATENT APPLICATION PUBLICATIONS							
	*PATENT APPLN. PUB. NO.	N.		PPLICANT	CLASS	SUBCLASS/	
 					\ 	 	
		L U	.S. PATENT AP	PLICATIONS	1	' 	
*APPLN. *FILING							
	NO.	DATE	۱۱ ۰ سر	VENTOR	CLASS	SUBCLASS	
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO. DAT		COUNTRY		CLASS	SUBCLASS	Translation Yes No
W	JP 2003-504935	4/2/2003	Japan (full text)		1		X
ω	2001-157251 6/8/2001		Japan (full text & English Abstract)				-
c~	2003-516021	7/5/2003	Japan (ful	l text)	1 /		Х
					1/		
					1/	· \	
OTHER A	ART (Including A	uthor, Title. [Date. Pertine	nt Pages. Publish	er. Place	of Publication	n. Etc.)
3	ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.) "CPCH ACCESS METHODS COMPARISON" TSG-RAN Working Group 1 meeting #10 Bejing (China), January 18 - January 21, 2000 (TSGR1#10(00)0106)						
ev	"DYNAMIC OVSF CODE ASSIGNMENT FOR PCPCH MESSAGE PART", TSG-RAN Working Group 1 meeting #10 January 18-21, Bejing, China (RSGR1#10(00)01)						
ω	JP Office Action dated December 7, 2004 (full text and English Translation)						
EXAMINER	Christins		. [1	DATE CONSIDERED 7/10/05			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.